

# SIGC104T170R2C

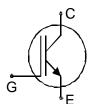
## IGBT Chip in NPT-technology

#### FEATURES:

- 1700V NPT technology •
- 280µm chip •
- short circuit prove •
- positive temperature coefficient
- easy paralleling

## This chip is used for:

- chip only •
- **Applications:** •
  - drives



Chip Type	V <sub>CE</sub>	<b>I</b> Cn	Die Size	Package	Ordering Code
SIGC104T170R2C	1700V	50A	10.12 x 10.18 mm <sup>2</sup>	sawn on foil	Q67041-A4695- A001

#### MECHANICAL PARAMETER:

Raster size	10.12 x 10.18			
Area total / active	103 / 71.5			
Emitter pad size	8x( 1.78x2.58 )			
Gate pad size	0.757 x 1.48			
Thickness	280	μm		
Wafer size	150	mm		
Flat position	90	deg		
Max.possible chips per wafer	130 pcs			
Passivation frontside	Photoimide			
Emitter metalization	3200 nm Al Si 1%			
Collector metalization	1400 nm Ni Ag –system suitable for epoxy and soft solder die bonding			
Die bond	electrically conductive glue or solder			
Wire bond	AI, ≤500µm			
Reject Ink Dot Size	Ø 0.65mm ; max 1.2mm			
Recommended Storage Environment	store in original container, in dry nitrogen, < 6 month at an ambient temperature of 23°C			



MAXIMUM RATINGS:

Parameter	Symbol	Value	Unit
Collector-emitter voltage, Tj=25 °C	V <sub>CE</sub>	1700	V
DC collector current, limited by T <sub>jmax</sub>	I <sub>C</sub>	1)	А
Pulsed collector current, $t_p$ limited by $T_{jmax}$	I <sub>cpuls</sub>	150	А
Gate emitter voltage	V <sub>GE</sub>	±20	V
Operating junction and storage temperature	T <sub>j</sub> , T <sub>stg</sub>	-55 +150	°C

<sup>1)</sup> depending on thermal properties of assembly

**STATIC CHARACTERISTICS** (tested on chip),  $T_j$ =25 °C, unless otherwise specified:

Parameter	Symbol	Conditions	Value			Unit
			min.	typ.	max.	
Collector-emitter breakdown voltage	V <sub>(BR)CES</sub>	$V_{GE}$ =0V , I <sub>C</sub> =3mA	1700			
Collector-emitter saturation voltage	V <sub>CE(sat)</sub>	V <sub>GE</sub> =15V, I <sub>C</sub> =50A	2.2	2.7	3.2	V
Gate-emitter threshold voltage	V <sub>GE(th)</sub>	$I_{C}{=}2.2mA$ , $V_{GE}{=}V_{CE}$	4.5	5.5	6.5	
Zero gate voltage collector current	I <sub>CES</sub>	V <sub>CE</sub> =1700V , V <sub>GE</sub> =0V			600	μA
Gate-emitter leakage current	I <sub>GES</sub>	$V_{CE}=0V$ , $V_{GE}=20V$			300	nA
Integrated gate resistor	R <sub>Gint</sub>			5		Ω

## **DYNAMIC CHARACTERISTICS** (tested at component):

Parameter	Symbol	Conditions	Value			Unit
Farameter	Symbol		min.	typ.	max.	Unit
Input capacitance	Ciss	V <sub>CE</sub> =25V,	-	tbd	-	nF
Output capacitance	Coss	$V_{GE}=0V$ ,	-	tbd	-	
Reverse transfer capacitance	Crss	f=1MHz	-	tbd	-	

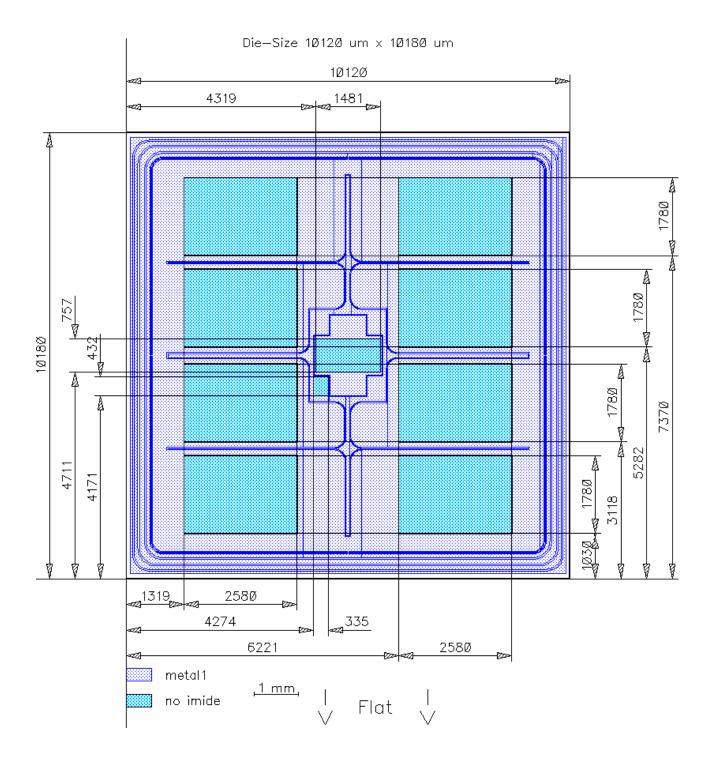
## SWITCHING CHARACTERISTICS (tested at component), Inductive Load:

Parameter	Symbol	Conditions <sup>1)</sup>	Value			Unit
T diameter			min.	typ.	max.	
Turn-on delay time	t <sub>d(on)</sub>	<i>T</i> <sub>j</sub> =125°C <i>V</i> <sub>CC</sub> =1200V, <i>I</i> <sub>C</sub> =50A	-	tbd	-	ns
Rise time	<i>t</i> r	I <sub>C</sub> =50A	-	tbd	-	
Turn-off delay time	t <sub>d(off)</sub>	$V_{GE}=\pm 15V,$ $R_{G}=27\Omega$	-	tbd	-	
Fall time	t <sub>f</sub>	116-2132	-	tbd	-	

<sup>1)</sup> values also influenced by parasitic L- and C- in measurement and package.



## **CHIP DRAWING:**





#### FURTHER ELECTRICAL CHARACTERISTICS:

This chip data sheet refers to the device data sheet

chip only

#### **Description:**

AQL 0,65 for visual inspection according to failure catalog

Electrostatic Discharge Sensitive Device according to MIL-STD 883

Test-Normen Villach/Prüffeld

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